## Notice of References Cited Application/Control No. 08/764,110 Examiner Mark L. Berch Applicant(s)/Patent Under Reexamination CHEN, YUHPYNG L. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,552,192 B1	04-2003	Hanus et al.	544/280
	В	US-			
	С	US-			5 Mg (4)
	D	US-			
	Е	US-			
	F	US-	,		
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	- Country	Name	Classification
	N					
	0				_	
	Р					
	Q					
	R					
	S					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	C					
	٧					
	w					
	x					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.